

● PRINTER RUSH ●
(PTO ASSISTANCE)

Application : 10/080 560 Examiner : Heneghan GAU : 2134

From: LAS Location: IDC FMF FDC Date: 7/20/05

Tracking #: epm 10/080 560 Week Date: 3/28/05

DOC CODE	DOC DATE	MISCELLANEOUS
<input checked="" type="checkbox"/> 1449	10 - 1 - 2004 Page 2 of 2	<input type="checkbox"/> Continuing Data
<input type="checkbox"/> IDS		<input type="checkbox"/> Foreign Priority
<input type="checkbox"/> CLM		<input type="checkbox"/> Document Legibility
<input type="checkbox"/> IIFW		<input type="checkbox"/> Fees
<input type="checkbox"/> SRFW		<input type="checkbox"/> Other
<input type="checkbox"/> DRW		
<input type="checkbox"/> OATH		
<input type="checkbox"/> 312		
<input type="checkbox"/> SPEC		

[RUSH] MESSAGE:

*Please verify U.S. Reference RE 31,375, 11/13/1984,
Davidson.*

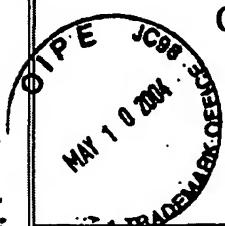
Thanks you

[XRUSH] RESPONSE: *Correct number is RE 31735.*

INITIALS: *dag*

NOTE: This form will be included as part of the official USPTO record, with the Response document coded as XRUSH.
 REV 10/04

#14


**INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION**

(PTO-1449)

ATTY. DOCKET NO.
070602-0247SERIAL NO.
10/080,560APPLICANT
Jack Elias SeitnerFILING DATE
February 25, 2002GROUP
2313**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) (if known)	Publication Date MM-DD-YYYY	Name of Patent or Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
MM 9/27/04	1.	US 2003/0118166 A1	08/26/2003	Gilley	
MM 9/27/04	2.	US 2001/0036274 A1	11/01/2001	Antoine	
MM 9/27/04	3.	US Re. 31,976 735	11/13/1984	Davidson	
MM 9/27/04	4.	US 5,912,973	08/15/1999	Hiramatsu, et al.	
MM 9/27/04	5.	US 5,894,517	04/13/1999	Hutchison, et al.	
MM 9/27/04	6.	US 5,745,522	04/28/1998	Heegard	
MM 9/27/04	7.	US 5,561,714	10/01/1996	Hershberger	
MM 9/27/04	8.	US 5,555,305	09/10/1996	Robinson, et al.	
MM 9/27/04	9.	US 5,530,758	08/25/1996	Bourel, et al.	
MM 9/27/04	10.	US 5,283,631	02/01/1994	Cook, et al.	
MM 9/27/04	11.	US 5,278,907	01/11/1994	Snyder, et al.	
MM 9/27/04	12.	US 5,144,668	09/01/1992	Faulkner, et al.	
MM 9/27/04	13.	US 4,972,480	11/20/1990	Rosen	
MM 9/27/04	14.	US 4,780,013	12/06/1988	Kage	
MM 9/27/04	15.	US 4,771,463	09/13/1988	Beeman	
MM 9/27/04	16.	US 4,752,953	06/21/1988	Paik, et al.	
MM 9/27/04	17.	US 4,723,246	02/02/1988	Weldon, Jr.	
MM 9/27/04	18.	US 4,688,218	08/18/1987	Bluneau, et al.	
MM 9/27/04	19.	US 4,208,739	06/17/1980	Lu, et al.	
MM 9/27/04	20.	US 4,071,692	01/31/1978	Weir, et al.	
MM 9/27/04	21.	US 3,610,828	10/05/1971	Girard, et al.	

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5/25/05**FOREIGN PATENT DOCUMENTS**

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code-Number & Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER

M. STZ

DATE CONSIDERED

9/27/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

ORC 336463-1.070602.0247